### FDD5614P

SEMICONDUCTOR IM

### 60V P-Channel PowerTrench<sup>®</sup> MOSFET

#### **General Description**

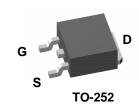
This 60V P-Channel MOSFET uses Fairchild's high voltage PowerTrench process. It has been optimized for power management applications.

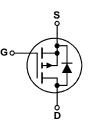
#### Applications

- DC/DC converter
- Power management
- Load switch

#### Features

- -15 A, -60 V.  $R_{DS(ON)}$  = 100 m $\Omega$  @ V<sub>GS</sub> = -10 V  $R_{DS(ON)}$  = 130 m $\Omega$  @ V<sub>GS</sub> = -4.5 V
- Fast switching speed
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- High power and current handling capability





### Absolute Maximum Ratings T<sub>A=25°C</sub> unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		-60	V
V <sub>GSS</sub>	Gate-Source Voltage		±20	V
ID	Drain Current – Continuous	(Note 3)	-15	A
	– Pulsed	(Note 1a)	-45	
PD	Power Dissipation for Single Operation	(Note 1)	42	W
		(Note 1a)	3.8	
		(Note 1b)	1.6	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Tempe	erature Range	-55 to +175	°C
Therma	I Characteristics			
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	3.5	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambie	ent (Note 1a)	40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambie	ent (Note 1b)	96	°C/M
Packag	e Marking and Ordering Ir	formation		
Device		Reel Size	Tape width	Quantity

Device Marking	Device	Reel Size	Tape width	Quantity
FDD5614P	FDD5614P	13"	12mm	2500 units
	•		•	

Min Тур Max Units 90 mJ -4.5 А V -49 mV/∘C -1 μΑ 100 nA -100 nA

-60

#### On Characteristics (Note 2)

Current **Off Characteristics** 

Coefficient

**Electrical Characteristics** 

Parameter

Maximum Drain-Source Avalanche

Drain-Source Breakdown Voltage

Breakdown Voltage Temperature

Zero Gate Voltage Drain Current

Gate-Body Leakage, Forward

Gate-Body Leakage, Reverse

Drain-Source Avalanche Ratings (Note 1) Single Pulse Drain-Source

Avalanche Energy

Symbol

 $W_{\text{DSS}}$ 

 $I_{AR}$ 

BV<sub>DSS</sub>

 $\Delta BV_{DSS}$ 

 $\Delta T_{J}$ 

I<sub>DSS</sub>

 $\mathbf{I}_{\text{GSSF}}$ 

 $I_{GSSR}$ 

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$	-1	-1.6	-3	V
$\frac{\Delta V_{\text{GS(th)}}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A}$ , Referenced to $25^{\circ}\text{C}$		4		mV/°C
$R_{\text{DS(on)}}$	Static Drain–Source On–Resistance	$ \begin{array}{ll} V_{GS} = -10 \ V, & I_D = -4.5 \ A \\ V_{GS} = -4.5 \ V, & I_D = -3.9 \ A \\ V_{GS} = -10 \ V, I_D = -4.5 \ A, T_J = 125^\circ C \end{array} $		76 99 137	100 130 185	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = -10 \text{ V}, \qquad V_{DS} = -5 \text{ V}$	-20			А
<b>g</b> FS	Forward Transconductance	$V_{\text{DS}} = -5 \text{ V}, \qquad I_{\text{D}} = -3 \text{ A}$		8		S

 $T_A = 25^{\circ}C$  unless otherwise noted

 $V_{\text{DD}} = -30 \text{ V}, \quad I_{\text{D}} = -4.5 \text{ A}$ 

 $V_{GS}$  = 0 V,  $I_D$  = -250  $\mu$ A

 $V_{DS} = -48 V$ ,

 $V_{GS} = -20 V$ ,

 $V_{GS} = 20V$ ,

 $I_D = -250 \ \mu\text{A}$ , Referenced to  $25^{\circ}\text{C}$ 

 $V_{GS} = 0 V$ 

 $V_{\text{DS}} = 0 \ V$ 

 $V_{DS} = 0 V$ 

**Test Conditions** 

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	$V_{DS} = -30 \text{ V},  V_{GS} = 0 \text{ V},$	759	pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz	90	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		39	pF

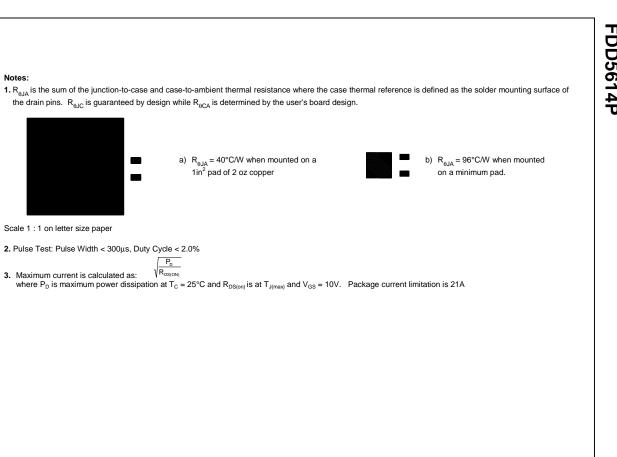
#### Switching Characteristics (Note 2)

t <sub>d(on)</sub>	Turn–On Delay Time	$V_{DD} = -30 V,$	$I_{\rm D} = -1  {\rm A},$	7	14	ns
t <sub>r</sub>	Turn–On Rise Time	$V_{GS} = -10 V,$	$R_{GEN} = 6 \Omega$	10	20	ns
t <sub>d(off)</sub>	Turn–Off Delay Time			19	34	ns
t <sub>f</sub>	Turn–Off Fall Time			12	22	ns
Qg	Total Gate Charge		I <sub>D</sub> = -4.5 A,	15	24	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = -10 V$		2.5		nC
Q <sub>gd</sub>	Gate-Drain Charge			3.0		nC

#### Drain–Source Diode Characteristics and Maximum Ratings

ls	Maximum Continuous Drain–Source Diode Forward Current				-3.2	А
$V_{\text{SD}}$	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$ , $I_S = -3.2 A$ (Note 2)		-0.8	-1.2	V

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Notes:

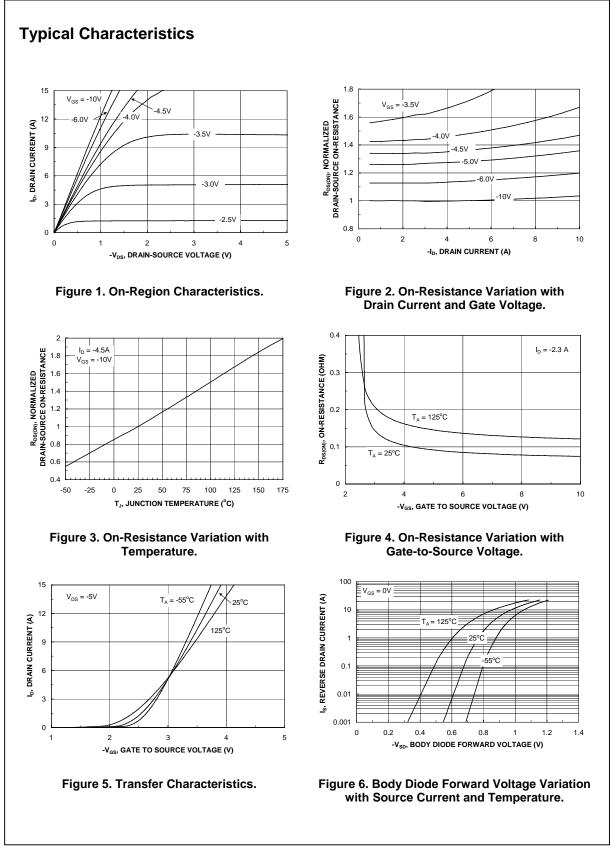
Scale 1 : 1 on letter size paper

3. Maximum current is calculated as:

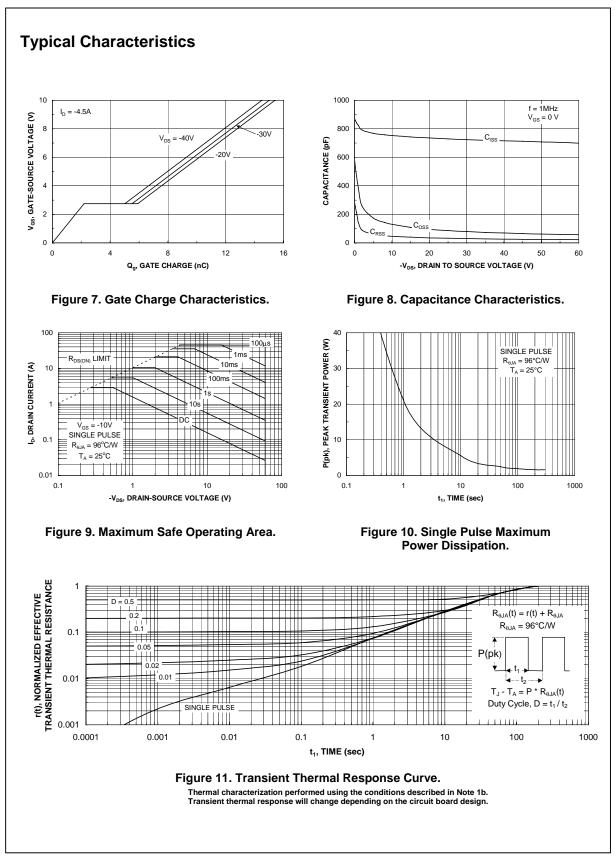
2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

 $\sqrt{\frac{P_D}{R_{DS(ON)}}}$ 

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## FDD5614P



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FDD5614P Rev C(W)

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PowerTrench<sup>®</sup> QFET™ QS™ QT Optoelectronics<sup>™</sup> Quiet Series<sup>™</sup> SILENT SWITCHER® SMART START™ SuperSOT<sup>™</sup>-3 SuperSOT<sup>™</sup>-6 SuperSOT<sup>™</sup>-8

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